


<b>Search Notes</b>  	<b>Application/Control No.</b>  10562766	<b>Applicant(s)/Patent Under Reexamination</b>  TOCHON-DANGUY ET AL.
	<b>Examiner</b>  JASON K NIESZ	<b>Art Unit</b>  3751

SEARCHED			
Class	Subclass	Date	Examiner
141	97, 25, 26, 27, 100, 102, 104, 105	07/17/2008	JN
600	5	07/17/2008	JN

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Loan Thanh	07/17/2008	JN
Consulted Tim Maust	07/17/2008	JN
PLUS Search	07/18/2008	JN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner